

Jornadas SAM-CONAMET 2001 Convenes September 12–14 in Posadas, Argentina

Jornadas SAM is the annual meeting of the SAM-Asociacion Argentina de Materiales/Materials Research Society of Argentina, a meeting that has been organized since 1955. Through an agreement between MRS-Argentina and the Chilean Society of Metallurgy and Materials, for the first time the Jornadas SAM will be organized together with CONAMET, a Chilean meeting. C. Schvezov (Misiones University, Argentina) is president and R.P. Hillerns (Universidad de Chile) is vice president of the organizing committee.

Jornadas SAM-CONAMET is an international meeting with the main purpose of connecting researchers from the Latino-

American countries dedicated to materials science and technology. The languages of the meeting's oral and poster presentations are Spanish, Portuguese, or English. Topics include extraction and production in metallurgy; melting solidification and welding; pulvimetallurgy; physical metallurgy; plastic deformation and mechanical properties; thermal treatment and phase transformations; fracture and fatigue; corrosion and methods for protection; defect fault analysis; historical metallurgy; polymers; ceramics, refractory, and vitreous materials; composites; thin films and treatment of surfaces; semiconductor, superconductor, and ionic conductor ma-

terials; new materials; and technological steps and human resources.

Abstracts in Spanish, Portuguese, or English of no more than 200 words can be submitted by e-mail to sam_conamet@fceqyn.unam.edu.ar or schvezov@fceqyn.unam.edu.ar. The abstract deadline is **April 7, 2001**. Notification of acceptance will be made by May 23, 2001. For more information, write to Jornadas SAM-CONAMET 2001, Facultad de Ciencias Exáctas, Químicas y Naturales, Azara 1552, 3300 Posadas, Misiones, Argentina.



C-MRS to Sponsor IUMRS-ICEM 2002 in Xi'an, China

The Chinese Materials Research Society (C-MRS) will sponsor the International Union of Materials Research Societies 8th International Conference on Electronic Materials (IUMRS-ICEM 2002) on June 10–14,

2002, in Xi'an, China. Chaired by L. Zhou, President of C-MRS, the meeting's topics will include nanomaterials and structure; wide-bandgap materials for electronic and optoelectronic devices; materials and

technologies for electronic and optoelectronic devices; silicon-based heterostructure materials; molecular and biomolecular electronics; physical phenomena and application of photorefractive materials; advanced materials and devices for large-area electronics; advanced characteristics of electronic materials; magnetic materials and devices; optical data-storage materials, mechanisms, and emerging technologies; crystal chemistry of functional materials; high- T_c materials for electronic applications; silicon materials for ULSI; advanced electroceramic materials; theory and modeling for electronic materials; and ferroelectric and high- κ materials. The conference will include an equipment exhibit, and the official oral and written language of the conference is English.

The deadline for submission of final, corrected abstracts is **February 28, 2002**.

For more information, contact Prof. Jianhua Cheng, C-MRS, tel. 86-10-68944280, fax 86-10-68428640, or e-mail cmrssec@public.bta.net.cn. Prof. Yafang Han, C-MRS, is the General Secretary. The meeting's Web site is located at www.c-mrs.org.cn/icem2002.



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